

ED STATES PATENT AND TRADEMARK OFFICE

11-50-05 #42

In re Application of

GILBERT P. HYATT

Serial No. 06/848,017

Docket No. 307

Filed: April 3, 1986

For: AN INTEGRATED CIRCUIT FILTER

PROCESSOR

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APR 0 1 2005

Technology Center 2100

INFORMATION DISCLOSURE STATEMENT

Hon. Commissioner For Patents

P.O. Box 1450, Alexandria, VA 22313-1450

Transmitted herewith is an Information Disclosure Citation (IDC) listing references for consideration by the Examiner.

The Applicant requests consideration by the Examiner of the references listed on the IDC transmitted herewith and initialing of the references listed on the IDC.

Copies of the references (except for US patents) are being filed in the PTO contemporaneously herewith.

The listed references are relevant because they were cited by examiners in copending applications of the Applicant.

The instant Information Disclosure Statement is filed in accordance with directions provided by the PTO. $^{\! 1}$

^{1. &}lt;u>See</u> the Telephone Conference Records dated February 2, 1999 and February 17, 2004 regarding telephone conversations between SPE Hjerpe and Mr. Turner that took place on December 10, 1998; February 2, 1999; and February 10, 2004.

I hereby certify that each of the listed references was cited in one of the actions or in a Board decision in the copending applications listed hereinafter, which actions or Board decision were received no more than three months prior to the mailing of this statement.

DKT.	SERIAL NO.	DKT.	SERIAL NO.
558	$08/470,\overline{671}$	774	$08/469, \overline{077}$
601	08/431,639	790	08/469,889
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706	08/457,715	794	08/471,846
732	08/458,608	797	08/471,255
743	08/461,288		

Respectfully submitted,

Dated: March 28, 2005

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				Filing Date	Group Art Unit				
				April 3, 1986					
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL	DOCUMENT NUMBER	DATE		NAME	CLASS	SUBCLAS			
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	Heath; <u>Large-Scale Integration In Electronics</u> ; Scientific American (2/1970). McGraw-Hill Dictionary of Scientific and Technical Terms 416, 428, 1661, 1997, 2133 (5th ed., 1994).								
				Language 142, 674, 675, 104					

EXAMINER

DATE CONSIDERED

EXAMINER: Initial if citation considered, whether or not citation is in conformance with MPEP § 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to the applicant.